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CENTRAL FAX CENTER

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

OCT 07 2004

Serial No.: 10/647,714

Conf. No.: 2476

Filing Date: 08/25/2003

Art Unit: 2818

Applicant: Khan et al.

Examiner: Le, Thao P.

Title: METAL OXIDE SEMICONDUCTOR  
HETEROSTRUCTURE FIELD EFFECT  
TRANSISTOR

Docket No.: SETI-0002DIV

## COMMISSIONER FOR PATENTS

DESTINATION PHONE NUMBER: 703-872-9306

Transmitted herewith is: Amendment in 10 pages

in the above identified application.

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DATE: October 7, 2004

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CENTRAL FAX CENTER**OCT 07 2004****IN THE UNITED STATES PATENT AND TRADEMARK OFFICE****Serial No.:** 10/647,714**Conf. No.:** 2476**Filing Date:** 08/25/2003**Art Unit:** 2818**Applicant:** Khan et al.**Examiner:** Le, Thao P.**Title:** METAL OXIDE SEMICONDUCTOR  
HETEROSTRUCTURE FIELD EFFECT  
TRANSISTOR**Docket No.:** SETI-0002DIVMail Stop Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450**AMENDMENT**

Sir:

This paper is being filed in response to the Office Action dated July 14, 2004. Please  
amend the above-identified application as follows:

**Listing of Claims** begins on page 2 of this paper.

**Remarks** begin on page 7 of this paper.

Serial No. 10/647,714

Page 1 of 10

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